

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 11333-0026001	Application No. 10/784,138
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Felix Shchdrinsky	
		Filing Date February 20, 2004	Group Art Unit 2145

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
/M.N./	1	4,086,434	04-1978	Bocchi			
	2	4,412,292	10-1983	Sedam et al.			
	3	4,497,037	01-1985	Kato et al.			
	4	4,583,834	04-1986	Seko et al.			
	5	4,853,946	08-1998	Elliott et al.			
	6	4,962,368	10-1990	Dobrzanski et al.			
	7	4,964,065	10-1990	Hicks et al.			
	8	4,965,946	10-1990	Hegedus et al.			
	9	4,996,703	02-1991	Gray			
	10	5,038,319	08-1991	Carter et al.			
	11	5,057,866	10-1991	Hill, Jr. et al.			
	12	5,077,582	12-1991	Kravette et al.			
	13	5,084,875	01-1992	Weinberger et al.			
	14	5,129,080	07-1992	Smith			
	15	5,138,377	08-1992	Smith et al.			
	16	5,184,179	02-1993	Tarr et al.			
	17	5,204,699	04-1993	Birnbaum et al.			
	18	5,212,645	05-1993	Wildes et al.			
	19	5,214,772	05-1993	Weinberger et al.			
	20	5,216,461	06-1993	Maekawa et al.			
	21	5,220,380	06-1993	Hirata et al.			
	22	5,224,157	06-1993	Yamada et al.			
	23	5,243,382	09-1993	Takano et al.			
	24	5,257,069	10-1993	Hirata et al.			
	25	5,261,061	11-1993	Ju Cheol			
	26	5,270,775	12-1993	Suzuki			
	27	5,282,127	01-1994	Mii			

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U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
/M.N./	82	US2005/0015501	01-2005	Kaplan et al.			
	83	US2005/0033588	02-2005	Ruiz et al.			
	84	US2005/0055397	03-2005	Zhu et al.			
	85	US2005/0102388	05-2005	Tabbara et al.			
	86	US2005/0144612	06-2005	Wang et al.			
	87	US2005/0154787	07-2005	Cochran et al.			
	88	US2005/0193099	09-2005	Reus et al.			
	89	US2005/0193386	09-2005	McCaleb et al.			
	90	US2005/0246702	11-2005	Yeh et al.			
	91	US2005/0262076	11-2005	Voskuil			
	92	US2005/0256614	11-2005	Habermas			
	93	US2006/0031476	02-2006	Mathes et al.			
	94	US2006/0037022	02-2006	Byrd et al.			
	95	US2006/0059239	03-2006	Brasher et al.			
	96	US2006/0069753	03-2006	Hu et al.			
	97	US2006/0077941	04-2006	Alagappan et al.			
	98	US2006/0095370	05-2006	Seth et al.			
	99	US2006/0100972	05-2006	Chianese et al.			
	100	US2006/0135192	06-2006	Surendra et al.			
	101	US2006/0179143	08-2006	Walker et al.			
	102	US2006/0200494	09-2006	Sparks			
	103	US2006/0200307	09-2006	Riess			
	104	US2006/0224742	10-2006	Shabazi et al.			
	105	US2006/0236325	10-2006	Rao et al.			
	106	US2006/0282521	12-2006	Anderson et al.			
	107	US2006/0087408	01-2007	Korzeniowski			4-27-2006
	108	US2006/0087409	01-2007	Korzeniowski			4-27-2006

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U.S. Patent Documents							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	109						
	110						
	111						

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
/M.N./	112	1 695 485	08-2006	EPO				
	113	1 362 282	11-2003	EPO				
	114	60-263162	12-1985	Japan				
	115	2003-223603	08-2003	Japan				
	116	2000-278773	10-2000	Japan				
	117	WO97/30879	01-2007 8-28-1997	WIPO				
	118	WO03/021464	03-2003	WIPO				
	119	WO03/054439	07-2003	WIPO				
	120	WO04/059447	07-2004	WIPO				
	121	WO06/009402	01-2006	WIPO				
	122	WO08/83177	07-2008	WIPO				

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
/M.N./	123	Bock, G., "Mainstreaming XML-based Enterprise Applications: Using Oracle XML DB to Manage Financial Information within a Global Banking System", Oracle Corporation, (C) 2003.
	124	Chandler, T. et al., "The Technology Development of Automatic Metering and Monitoring Systems", Int'l Power Engineering Conf. 2005, IEEE, 4 pgs.
	125	EmWare Press Release: "emWare Delivers EMIT 3.0 SDK Pro-A Complete Device Networking Kit for Developing End-to-end, Embedded Device Networking Solutions," Salt Lake City, UT (May 1999).
	126	Franklin, M. et al., "Data in Your Face: PUSH Technology in Perspective", Proc. ACM SIGMOD Int'l Conf. on Mgmt of Data, (06-1998), #XP000886180, pgs. 516-519,

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